## Application/Control No. Applicant(s)/Patent Under Reexamination 10/781,870 LIAO ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 John S. Chu 1752 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY Α US-2005/0123674 A1 06-2005 Stasiak et al. 427/062 В US-2003/0205657 A1 11-2003 Voisin, Ronald D. 249/187.1 С US-2003/0205658 A1 11-2003 Voisin, Ronald D. 249/187.1 D US-US-Ε F US-US-G US-Н US-1 J US-Κ US-US-L US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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